## **ELECTRONIC INFORMATION DISCLOSURE STATEMENT**

Electronic Version v18 Stylesheet Version v18.0

> Title of Invention

METHODS AND SYSTEMS FOR INSPECTING A SPECIMEN USING LIGHT SCATTERED IN DIFFERENT WAVELENGTH RANGES

Application Number:

10/719347

**Confirmation Number:** 

3303

First Named Applicant:

**David Shortt** Attorney Docket Number: 5589-06700

Search string:

( RE37740 or 4556903 or 6597000 or 4844617

or 5771094 or 5717518 or 5956174 or 6133576

or 6313467 or 6538730 or 6201601 or

6271916 ).pn.

## **US Patent Documents**

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
	1	RE37740	2002-06-11	Chadwick et al.	لـــــــــــــــــــــــــــــــــــــ		
	2	4556903	* 1985-12-03	Blitchington et al.			
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	4	4844617	1989-07-04	Kelderman et al.			
	5	5771094	1998-06-23	Carter et al.			
<b>⊘</b>	6	5717518	1998-02-10	Shafer et al.			•
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	11	6201601	2001-03-13	Vaez-Iravani et al.			•
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## Signature

Examiner Name	Date
D/ 2	12/05/05

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Page 1 of 2

